## Notice of References Cited Application/Control No. 10/807,259 Examiner Edward Park Applicant(s)/Patent Under Reexamination WATANABE ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0161537 a1	08-2003	Maeda et al.	382/218
*	В	US-2003/0161504 a1	08-2003	Inoue, Akira	382/115
*	C	US-6,806,903 b1	10-2004	Okisu et al.	348/254
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1043689 A2	10-2000	European Patent	WATANABE et al.	
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.